### Semiconductors Final Exam Equation Sheet

### Chapter 2: Intro to Q.M

Classic. var. Quantum operator 
$$x \to x \to x \\ f(x) \to f(x)$$
 
$$p(x) \to \frac{\hbar}{j} \frac{\partial}{\partial x} \\ E \to -\frac{\hbar}{j} \frac{\partial}{\partial t} \\ \langle Q_{op} \rangle = \int_{-\infty}^{\infty} \Psi^* Q_{op} \Psi dx \\ \langle P_x \rangle = \int_{-\infty}^{\infty} (\Psi^*) \left( \frac{\hbar}{j} \frac{\partial}{\partial x} \right) \Psi dx \\ (\Delta P_x) = \frac{\int_{-\infty}^{\infty} \Psi^* \left( \frac{\hbar}{j} \frac{\partial}{\partial x} \right) \Psi dx}{\int_{-\infty}^{\infty} \Psi^* \Psi dx} \text{ (normalized)} \\ (\Delta E) = \langle E \rangle = \int_{-\infty}^{\infty} \Psi^* \left( -\frac{\hbar}{j} \frac{\partial}{\partial x} \right) \Psi dx \\ (\Delta P_x) (\Delta x) \geq \frac{\hbar}{2}, \quad (\Delta E) (\Delta t) \geq \frac{\hbar}{2}$$

# Chapter 3: Energy Bands

$$\begin{split} f(E) &= \frac{1}{1 + e^{(E - E_f)/kT}} \\ N_A &= p_{no} f(E_A), \ N_D = n_{no} (1 - f(E_D)) \\ n_{no} p_{no} &= n_i^2, \ n_{po} p_{po} = n_i^2 \\ q \phi_f &= E_f - E_i = kT \ln \frac{N_D}{n_i} \text{ or } kT \ln \frac{N_A}{n_i} \\ J &= \frac{I}{A} = \sigma \vec{\varepsilon} = Qv \\ \sigma_n &= q \mu_n n_n \text{ or } \sigma_p = q \mu_p p_p \\ \text{if } \varepsilon &< \varepsilon_c, \text{ use } \begin{cases} J_n &= q \mu_n n_n \vec{\varepsilon} \\ J_p &= q \mu_p p_p \vec{\varepsilon} \end{cases} \\ \text{if } \varepsilon &> \varepsilon_c, \text{ use } \begin{cases} J_n &= q n_n v_{sat} \\ J_p &= q p_p v_{sat} \end{cases} \end{split}$$

## Chapter 5: P-N Junctions

$$\begin{aligned} & \text{Chapter 5: P-N Junctions} \\ & qV_0 = kT \ln \frac{N_D N_A}{n_i^2} \\ & \delta_n(x) = \Delta n_p e^{-x_p/L_n} \text{ (p side)} \\ & \Delta n_p = n_{po} \left( e^{qV/kT} - 1 \right) \\ & \delta_p(x) = \Delta p_n e^{-x_n/L_p} \text{ (n side)} \\ & \Delta p_n = p_{no} \left( e^{qV/kT} - 1 \right) \\ & W_D \bigg|_{eq} = \sqrt{\frac{2\epsilon_s}{q} V_o \left( \frac{1}{N_A} + \frac{1}{N_D} \right)} \\ & W_D \bigg|_{\text{r.bias}} = \sqrt{\frac{2\epsilon_s}{q} (V_o - V_F) \left( \frac{1}{N_A} + \frac{1}{N_D} \right)} \\ & W_D \bigg|_{\text{r.bias}} = \sqrt{\frac{2\epsilon_s}{q} (V_o + V_R) \left( \frac{1}{N_A} + \frac{1}{N_D} \right)} \\ & D_p = \frac{kT}{q} \mu_p, \ L_p = \sqrt{D_p \tau_p} \\ & D_n = \frac{kT}{q} \mu_n, \ L_n = \sqrt{D_n \tau_n} \\ & I_o = qA \left[ \frac{D_p}{L_p} p_n + \frac{D_n}{L_n} n_p \right] \\ & I = I_o \left( e^{qV/kT} - 1 \right) \\ & V \equiv \text{applied voltage} \\ & I(V_{r.bias}) \approx -I_o \\ & C_j = \frac{\epsilon_s}{W_D} \\ \hline & \text{p-type} & \phi_m > \phi_s & \phi_m < \phi_s \\ & \text{n-type} & \phi_m < \phi_s & \phi_m > \phi_s \\ \end{bmatrix}$$

### Chapter 6: Field Effect Transistors

$$\begin{split} &\frac{JFETs}{V_o = \frac{kT}{q}\ln\frac{N_AN_D}{n_i}}\\ &W = \sqrt{\frac{2\epsilon_s}{q}\left(\frac{1}{N_A} + \frac{1}{N_A}\right)\left(V_o + |V_R|\right)}\\ &\text{if } V_o + |V_R| \geq V_P \Rightarrow W = a\\ &|V_R| = |V_G| + |V_D|\\ &|V_P| = |V_o| + |V_G| + |V_D|\\ &\text{p-type: } V_P = \frac{a^2qN_A}{2\epsilon_s}\\ &\text{n-type: } V_P = \frac{a^2qN_D}{2\epsilon_s}\\ &|V_{D_Sat}| = |V_P| - |V_G| - |V_o| \end{split}$$

### MOSFET

$$\begin{split} \overline{V_T(\text{ideal})} &= V_T = \frac{Q_D}{C_i} + 2\phi_f \\ \text{n-channel: } V_T &= \left|\frac{Q_D}{C_i}\right| + |2\phi_f| \\ \text{p-channel: } V_T &= -\left|\frac{Q_D}{C_i}\right| - |2\phi_f| \\ \text{Non-Ideal: } V_{FB} &= -\left|\frac{Q_i}{C_i}\right| - |\Phi_{ms}| \\ \Phi_{ms} &= \phi_m - \phi_s \\ V_T &= V_{FB} + V_T(\text{ideal}) \\ V_{D_{sat}} &= V_G - V_T \end{split}$$

$$\begin{split} Q_D &= qN_AW_m,\, \phi_f = \frac{kT}{q}\ln\frac{N_A}{n_i}\\ W_m &= \sqrt{\frac{2\epsilon_s}{qN_A}(2\phi_f + |V_{sb}|)}\\ C_i &= C_{oxide} = \frac{\epsilon_{oxide}}{t_{oxide}}\\ \text{p-channel:}\\ Q_D &= qN_DW_m,\, \phi_f = \frac{kT}{q}\ln\frac{N_D}{n_i}\\ W_m &= \sqrt{\frac{2\epsilon_s}{qN_D}(2\phi_f + |V_{sb}|)}\\ C_i &= C_{oxide} = \frac{\epsilon_{oxide}}{t_{oxide}}\\ \text{Drain Current:}\\ \text{Linear:}\\ I_D &= \frac{z\mu C_i}{L}\left[(V_G - V_T)\,V_D - \frac{1}{2}V_D^2\right]\\ \text{Saturation:}\\ I_{Dsat} &= \frac{z\mu C_i}{2L}(V_G - V_T)^2\\ g &= g_m(\text{sat.}) \approx \frac{Z\mu C_i}{L}(V_G - V_T) \end{split}$$

### Chapter 7: BJTs

Relation between terminal currents:

The action between terminal current 
$$I_E = I_B + I_C$$
  $I_C = \beta_F I_B, \beta \gg 1$   $I_E = (1 + \beta)I_B$   $I_C = \alpha_F I_E, \alpha_F \lessapprox 1$   $\beta_F = \frac{\alpha_F}{1 - \alpha_F}$  Emitter Injection Efficiency: 
$$\gamma = \frac{i_{Ep}}{i_{En} + i_{Ep}}$$
 =  $\frac{\text{emitter hole component}}{\text{total emitter current}}$   $i_c = Bi_{Ep}$ 

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B: Base transport factor
 B: Base transport factor \alpha: current transfer ratio \alpha \equiv \frac{i_c}{i_E} = B\gamma = \frac{Bi_{E_p}}{i_{E_n} + i_{E_p}}
  \begin{array}{c} i_B: \text{base current} \\ i_B=i_{E_n}+(1-B)i_{E_P} \\ \beta: \text{ Base to Collector current amplification factor} \end{array}
  \beta = \frac{\alpha}{1 - \alpha} = \frac{\tau_p}{\tau_t}
\tau_p: \text{ Minority carrier lifetime } \tau_t: \text{ base transit time }
More general \gamma:
\gamma \approx \left[1 + \frac{W_b n_n \mu_n^p}{L_n^p p_p \mu_n^p}\right]^{-1}
I_E \approx q A \frac{D_p}{L_p} \Delta p_E \operatorname{ctnh} \frac{W_b}{L_p}
I_C \approx q A \frac{D_P}{L_P} \Delta p_E \operatorname{csch} \frac{W_b}{L_p}
I_B = I_E - I_C \approx q A \frac{D_P}{L_P} \Delta p_E \operatorname{tanh} \frac{W_b}{L_p}
\Delta p_E = p_{n_o} \left(e^{qV_{EB}/kT} - 1\right)
\Delta p_C = p_n \cdot \left(e^{qV_{CB}/kT} - 1\right)
  More general \gamma:
  \Delta p_C = p_{n_o} \left( e^{qV_{CB}/kT} - 1 \right)
  n_{n_o} \equiv N_D in the base region n_{n_o} \equiv hole concentration in the base region
 H_{n_o} = \text{finite concentration in } B = \frac{1}{\cosh\left[\frac{W_b}{L_p}\right]}
I_E = I_{E_n} + I_{E_p} \approx I_{E_p}
I_{E_n} = \frac{qAD_n^E}{L_{n_n}^E} n_p^E e^{qV_{EB}/kT}
  I_{E_p} = \frac{qAD_p^B}{L_p^B} p_n^B \operatorname{ctnh}\left(\frac{W_b}{L_p}\right) e^{qV_{EB}/kT}
   N-P-N:
  \overline{	ext{Emitter}} Injection Efficiency:
                \gamma = \frac{i_{E_n}}{i_{E_p} + i_{E_n}}
                       = emitter electron component
  = \frac{1}{i_c = Bi_{E_n}}total emitter current B: Base transport factor
 \alpha: current transfer ratio \alpha \equiv \frac{i_c}{i_E} = B\gamma = \frac{Bi_{E_n}}{i_{E_n} + i_{E_p}}
i_B: base current
  i_B=i_{E_p}+(1-B)i_{E_n}
\beta: Base to Collector current amplification factor
  \beta = \frac{\alpha}{1-\alpha} = \frac{\tau_n}{\tau_t} 
 \tau_p: Minority carrier lifetime
   \tau_t: base transit time
More general \gamma:
\gamma \approx \left[1 + \frac{W_b p_p \mu_p^n}{L_p^n n_n \mu_p^p}\right]^{-1}
I_E \approx q A \frac{D_n}{L_n} \Delta n_E \operatorname{ctnh} \frac{W_b}{L_n}
I_C \approx q A \frac{D_n}{L_n} \Delta n_E \operatorname{csch} \frac{W_b}{L_n}
I_B = I_E - I_C \approx q A \frac{D_n}{L_n} \Delta n_E \operatorname{tanh} \frac{W_b}{L_n}
\Delta n_E = n_{po} \left( e^{qV_{EB}/kT} - 1 \right)
\Delta n_C = n_{po} \left( e^{qV_{CB}/kT} - 1 \right)
  More general \gamma:
  \Delta n_C = n_{p_o} \left( e^{qV_{CB}/kT} - 1 \right)
  p_{p_o} \equiv N_A in the base region
   n_{p_o} \equiv electron concentration in the base region
  B = \frac{1}{\cosh\left[\frac{W_b}{L_p}\right]}
I_E = I_{E_n} + I_{E_p}
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\begin{array}{l} \textbf{Constants:} \\ q = 1.6 \times 10^{-19} \, \text{C} \\ \epsilon_0 = 8.85 \times 10^{-14} \, \text{Fm}^{-1}, \, \epsilon_{rSi} = 11.8 \\ \epsilon_r(\text{SiO}_2) = 3.9 \\ h = 6.626 \times 10^{-34} \, \text{m}^2 \, \text{kg/s}, \quad \hbar = 1.055 \times 10^{-31} \, \, \text{Js/rad} \\ m^* = 9.11 \times 10^{-31} \, \, \text{kg} \\ kT|_{T=300K} \approx 0.026 \, \, \text{eV} \\ n_i(Si)|_{300K} = 1.5 \times 10^{10} \, \, \text{cm}^{-3} \\ v_{th} = \text{Thermal Velocity} \approx 10^7 \, \, \text{cm/sec} \\ \vec{\varepsilon}_c = \text{critical field} = 10^4 \, \, \text{V/cm} \\ g(Si) = 4.05 \, \text{eV} \\ E_g(Si) = 1.14 \, \text{eV} \end{array}
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